

SCOPE OF ACCREDITATION

NonDestructive Testing

ENJET AERO MALDEN, LLC
60 Winter St
Malden, MA 02148

This certificate expiration is updated based on periodic audits. The current expiration date and scope of accreditation are listed at: www.eAuditNet.com - Online QML (Qualified Manufacturer Listing).

In recognition of the successful completion of the PRI evaluation process, accreditation is granted to this facility to perform the following:

AC7000 - AUDIT CRITERIA FOR NADCAP ACCREDITATION

AC7108/2 Rev H - Nadcap Audit Criteria for Etch Inspection Processes (Anodic Etch, Blue Etch Anodize, Macrostructure, Nital/Temper) – Download checklist from Chem Processing (to be used on audits on/AFTER 12-Jun-2022)

Pre–Penetrant Etch

Local (Swab) Etch – Pre–Penetrant Etch

AC7114 Rev R - Nadcap Audit Criteria for NonDestructive Testing (NDT) Auditees Accreditation Program (to be used on/AFTER 04-Dec-2022)

AC7114S Rev Q - Nadcap Supplemental Audit Criteria for NonDestructive Testing (NDT) Auditees Accreditation Program (to be used on audits on/AFTER 12-Feb-2023)

S–U1 Honeywell

S–U10 GE Aviation

AC7114/1 Rev O - Nadcap Audit Criteria for NonDestructive Testing Facility Penetrant Survey (to be used on/AFTER 04-Dec-2022)

AC7114/1S Rev O - Nadcap Supplemental Audit Criteria for NonDestructive Testing Facility Penetrant Survey (to be used on audits on/AFTER 12-Dec-2021)

S–U1 Honeywell

S–U10 GE Aviation

AC7114/10 Rev B - Nadcap Audit Criteria for NonDestructive Testing Facility Digital Radiography, Utilizing Digital Detector Array (DDA) & Computed Radiography (CR) Utilizing Photostimulable Luminescence (PSL) Survey (to be used on/after 02 May 2021)

CR

**AC7114/10S Rev A - Nadcap Supplemental Audit Criteria for NonDestructive Testing Facility
Digital Radiography, Utilizing Digital Detector Array (DDA)&Computed Radiography (CR)
Utilizing Photostimulable Luminescence (PSL) Survey (to be used on audits BEFORE 16-Apr-
2023)**
S-U10 GE Aviation